

## Microengineering Laser Plasma Interactions at Relativistic Intensities

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We report on the first successful proof-of-principle experiment to manipulate laser-matter interactions on microscales using highly ordered Si microwire arrays. The interaction of a high-contrast short-pulse laser with a flat target via periodic Si microwires yields a substantial enhancement in both the total and cutoff energies of the produced electron beam. The self-generated electric and magnetic fields behave as an electromagnetic lens that confines and guides electrons between the microwires as they acquire relativistic energies via direct laser acceleration.

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Laser-matter interactions at relativistic intensities have exhibited many interesting physical processes. These include the acceleration of electrons [1–4], protons, and heavy ions [5–7], the creation of electron-positron jets [8–10], and attosecond pulse generation [11,12]. The investigation of ultrashort pulse lasers interacting with initially solid-density matter has been mainly focused on flat targets, with little or no control over the interaction. Recently the focus has shifted toward using advanced targets with the aim of increasing laser beam absorption and subsequent energy partition among various plasma species. Structured interfaces including nanoparticles [13], snowflakes [14], and nanospheres [15] have been reported to enhance laser absorption and proton acceleration, and the trapping of femtosecond laser pulses of relativistic intensity deep within ordered nanowires resulted in volumetric heating of dense matter into a new ultrahot plasma regime [16]. Another proposal addressed the potential for prescribing geometrical structures on the front of a target to greatly enhance the yield of high-energy electrons while simultaneously confining the emission to narrow angular cones [17].

Microengineering laser plasma interactions, at intensities above the material damage threshold, has not been extensively explored. The main reason is that the amplified short pulses are inherently preceded by nanosecond-scale pedestals [18]. This departure from an ideal pulse can substantially modify or destroy any guiding features before the arrival of the intense portion of the pulse.

Laser-pulse cleaning techniques are now being employed to significantly minimize unwanted prepulse and pedestals. For example, Ti:sapphire-based short-pulse high-intensity lasers routinely use a cross-polarized wave generation technique to achieve a contrast of at least  $10^{10}$  on the nanosecond time scale [19]. The manufacturing of advanced micro- and nanostructures has been the domain of specialized

scientific disciplines such as nanoelectronics [20], microfluidics [21], and photovoltaics [22]. Microstructures with features as small as 200 nm can now be easily manufactured by nonexperts using commercially available 3D direct laser writing instruments [23]. Furthermore, 3D large-scale simulations with enough spatial and temporal resolution to capture the details of the interaction are now possible thanks to recent advances in massively parallel computing capabilities coupled with newly developed particle-in-cell (PIC) algorithms.

In this Letter, we first investigate the interaction of a high-contrast ultrashort pulse with highly ordered microwire arrays using the Virtual Laser Plasma Laboratory code in full 3D geometry [24]. We identify the mechanisms of relativistic electron-beam acceleration and guiding. Then, we report on the first successful proof-of-principle experiment to produce and control laser-driven electrons with nanoassembled Si microwires.

Our PIC investigation was carried out in a simulation box with  $48\lambda_0 \times 20\lambda_0 \times 20\lambda_0$  in the  $x \times y \times z$  directions, respectively ( $\lambda_0 = 0.8 \mu\text{m}$  is the laser wavelength). A laser pulse polarized in the  $y$  direction enters the simulation box from the left boundary along the  $x$  direction. The laser field amplitude has a profile of  $a_y = a_0 e^{-(r/\sigma_0)^2} \sin^2(\pi t/2\tau_0) \sin(\omega_0 t)$ , where  $\omega_0$  is the laser frequency and  $a_0 = eE_L/m_e\omega_0 c$  is the dimensionless laser electric field amplitude. Here  $e$ ,  $m_e$  are the fundamental charge and electron mass,  $E_L$  is the laser electric field, and  $c$  is the speed of light in vacuum. The laser amplitude, pulse duration, and spot size are  $a_0 = 21$ ,  $\tau_0 \approx 40$  fs, and  $\sigma_0 = 4\lambda_0$ , respectively. Periodic carbon microwires with a length of  $25\lambda_0$ , diameter of  $1.5\lambda_0$ , and spatial spacing of  $7\lambda_0$  are placed  $10\lambda_0$  from the left boundary. The electron density of the wires is  $n_e = 300n_c$  and they are attached to an aluminum foil of  $n_{\text{Al}} = 25n_c$  density ( $n_c = m_e\omega_0^2/4\pi e^2$  is the critical density). The entire target is

cold and preionized. In our simulations, we employed a periodic boundary condition for the laser field in the transverse ( $y$  and  $z$ ) directions and absorbing boundary conditions for the particles.

Snapshots of the interaction and electron-beam energy distributions from simulations are shown in Fig. 1. As the pulse enters the microwire array [Fig. 1(a)], electrons are pulled out of the wires by the laser field. These electron bunches are periodic and are separated by one laser wavelength on each wire. The electron bunches on two

opposite wires and on the same polarization plane are separated by half of the laser wavelength, reflecting the oscillatory nature of the driving laser field. The laser pulse has a phase velocity approximately equal to the speed of light as it propagates between the wires [Fig. 1(b)]. Consequently, electrons pulled from the surface of the wires are injected into the laser pulse and accelerated via a direct laser acceleration (DLA) mechanism [25]. Finally, when the laser beam reaches the flat interface, electrons originating from the wires have acquired significant kinetic

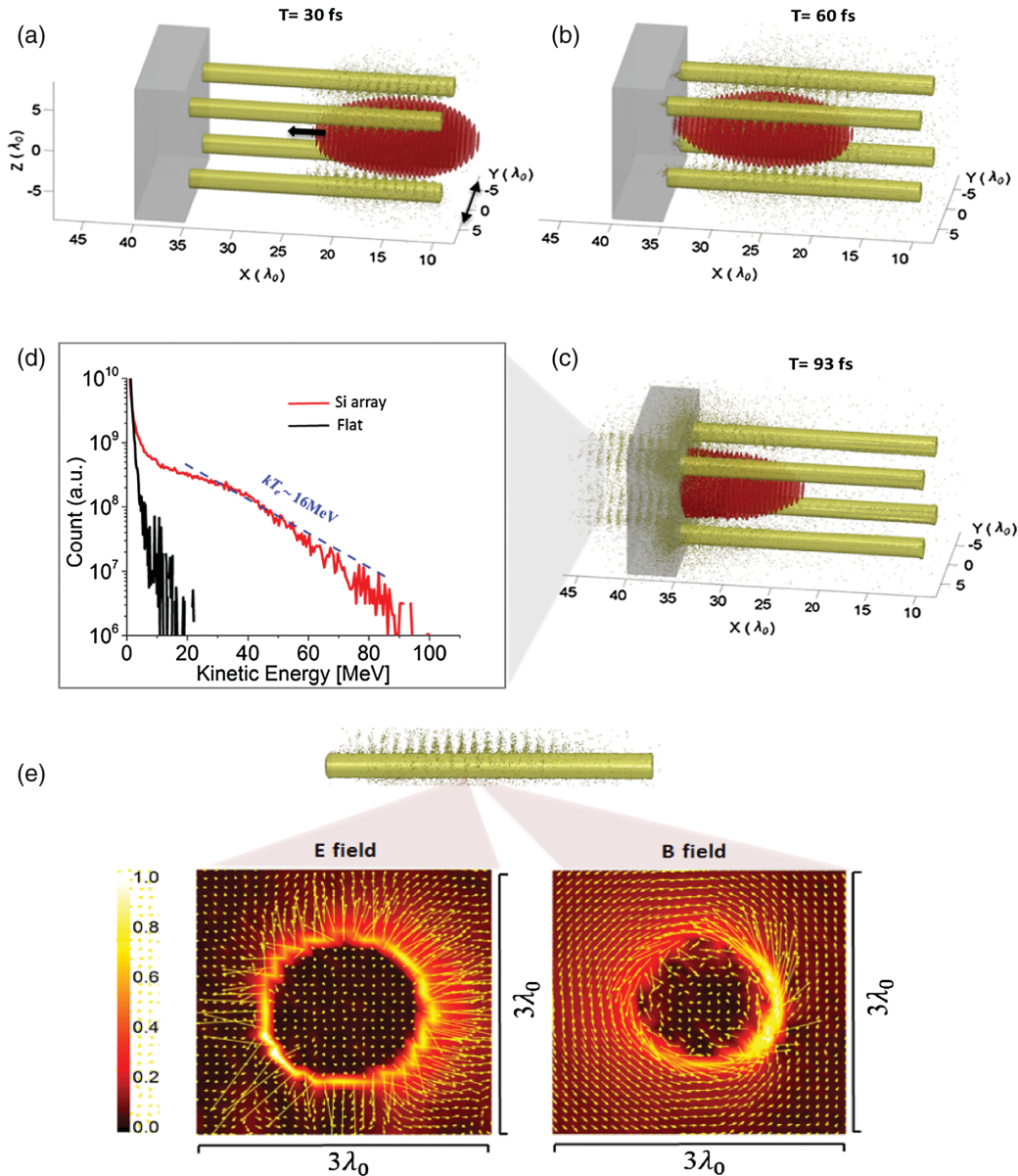


FIG. 1. Three-dimensional PIC simulations of an intense short-pulse laser interacting with microwire arrays: the laser pulse ( $I = 10^{21}$  W cm $^{-2}$ ) is polarized in the  $y$  direction [horizontal black double arrow in (a)] and propagates along the  $x$  direction from right to left. The target consists of highly aligned periodic carbon wires  $20 \mu\text{m}$  long and  $1.2 \mu\text{m}$  thick attached to  $5.6\text{-}\mu\text{m}$ -thick aluminum substrate. (a), (b), and (c) are snapshots of the interaction at  $t = 30$  fs,  $t = 60$  fs, and  $t = 93$  fs, respectively. (d) Electron-beam energy distributions from microwire array (red) and flat Al target (black). (e) Electric and magnetic fields around the wire (located at  $y = -4$ ,  $z = +4$ ), average over the wire length from the perspective antiparallel to the incoming laser pulse. In panel (e), the laser is toward the bottom-right corner.

energy. They propagate in the forward direction and escape the target, as indicated by the green periodic bunches at the rear side of the target [Fig. 1(c)]. It is worth noting that lower-energy electrons are also produced when the pulse irradiates the flat surface holding the wires. The most energetic electrons are the ones that originated from the wires and experienced acceleration via DLA. Figure 1(d) shows the electron energy distribution for the microwire array target. This distribution is obtained by counting all electrons moving in the  $+x$  direction. As a baseline comparison, we have carried out simulations of a flat interface without the wires using the same laser and simulation parameters. It is clear from these results that the performance of microengineered targets is superior to that of a flat target in producing and accelerating electrons. In the microwire array target, electrons with energies as high as 90 MeV are produced, compared to a maximum of 20 MeV electron energies in flat targets. An exponential fit to the electron energy distribution from the microwire array target yields  $kT_e = 16$  MeV, much higher than the ponderomotive scaling at the same intensity ( $kT_e = 7$  MeV) [26]. The total number of relativistic electrons with energies higher than 1 MeV is enhanced by a factor of 25 with the structured interface, as compared to flat targets. We also observe that the accelerated electrons travel forward in the vicinity of the wires. This suggests the presence of a guiding mechanism induced by laser plasma interactions.

We examined the electric and magnetic fields in the neighborhood of the wires. Figure 1(e) (left) shows a vector plot of the electric field surrounding one representative wire. The electric field is radially oriented and points away from the wire. This is consistent with fields induced by a distribution of positive charge. In our case, this field is induced by charge separation as the electrons are pulled from the wires by the laser, leaving the ions behind. Figure 1(e) (right) shows the magnetic field in the vicinity of the wire. The  $B$  field is taken when the observer looks in the direction opposite to that of the laser propagation. The orientation of the magnetic field and field line configuration is consistent with the magnetic field of current-carrying wire. The magnetic field is induced by the return currents in the wire as the plasma responds to electric current imbalance produced by the forward-going superthermal electrons. These plasma-produced electric and magnetic fields provide a guiding mechanism for electrons that are accelerated by DLA. The electric field induced by charge separation tends to attract electrons toward the wires. The magnetic field tends to push them away, toward the laser axis. Electrons with velocities such that the transverse electric and magnetic forces cancel one another are guided in the forward direction. The simulation results suggest that these advanced targets can be used as microphotonic devices to manipulate light-matter interaction on small scales and, subsequently, to control the production of secondary particle beams.

A proof-of-principle experiment was conducted on the Scarlet laser facility at The Ohio State University [27]. To manipulate light-matter interactions, we used Si microwire arrays [28]. Si{211} substrates were used to grow the periodic inclined Si wires. The surface of the substrate was first oxidized to form a layer of  $\text{SiO}_2$  a few hundred nanometers thick. Then, a thin layer of photoresist was applied using spin coating. The position and diameter of the microwires were prescribed by creating circular holes on the photoresist layer via photolithography. Using a buffered hydrofluoric acid etching, the uncovered  $\text{SiO}_2$  under the holes was removed to expose the pure Si. The holes were then filled up with a few hundred nanometers of Cu via thermal evaporation onto the photoresist, followed by lift-off to dispose of the photoresist layer. The substrate was then annealed and Si wires were grown through the vapor-liquid-solid growth method, while the other portion of the surface was still protected by the  $\text{SiO}_2$  layer. Silicon wires with diameter  $1.5 \mu\text{m}$ , length  $15\text{--}25 \mu\text{m}$ , and spacing  $7 \mu\text{m}$  were grown on a  $450\text{-}\mu\text{m}$ -thick flat Si substrate [Fig. 2(a)].

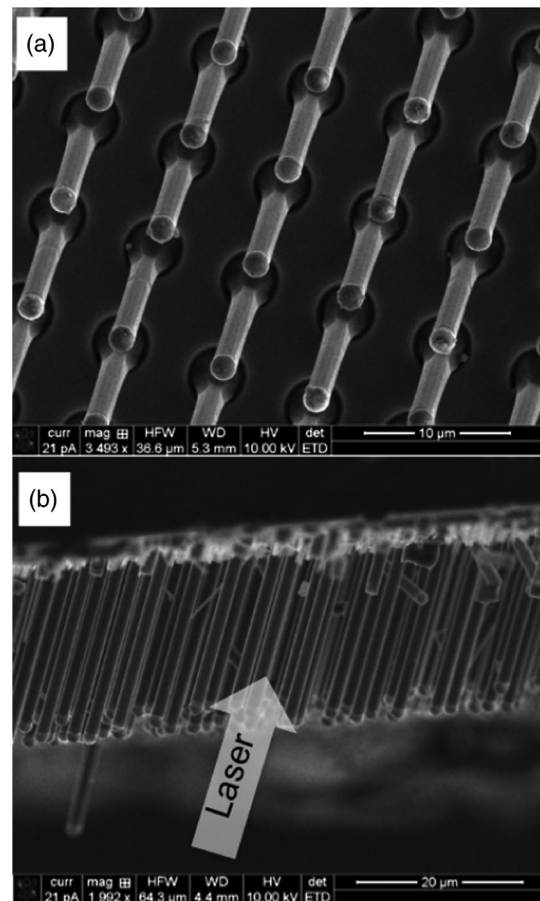


FIG. 2. Scanning electron microscope images of microphotonic targets. (a) Top view, showing wire spatial distribution. (b) Side view, showing the orientation of the wires with respect to the  $450\text{-}\mu\text{m}$ -thick flat Si substrate. Laser is incident parallel to the wires (white arrow).

The laser delivered 4–5 J of energy on target with the main pulse to an amplified spontaneous emission intensity contrast of better than  $10^9$ . The laser pulse of 40-fs duration focused with an  $F/2.2$  off-axis parabola to a 3- $\mu\text{m}$  full width at half maximum focal spot, reaching a peak intensity  $\sim 1 \times 10^{21} \text{ W cm}^{-2}$ . Target alignment was achieved using the confocal microscope position sensor technique [29]. To prevent laser back-reflections from damaging the front-end optics, the wires were grown at  $22.5^\circ$  with respect to the flat substrate normal [Fig. 2(b)]. The laser propagation direction was parallel to the wires, and electrons escaping the rear side of the target were collected with a magnetic spectrometer coupled to imaging plate detectors. The entrance slot of the electron spectrometer was 0.5 cm long and 250  $\mu\text{m}$  wide. The spectrometer spanned a total solid angle of about  $\sim 9.4 \times 10^{-5}$  sr. The energy range of the spectrometer was 0.5–70 MeV. To further ensure the accuracy of the energy measurement, when we calculated the trajectories of electrons with different energies, we also took into account the fringe magnetic field, which could have a large effect on the low-energy electrons. The relative error is a nonlinear function of electron energy and is about 3% for the low-energy electrons. The magnetic field in the center of the gap of our spectrometer is about 0.6 T and the instrument collected electrons at  $30^\circ$  from the laser axis and  $52.5^\circ$  from rear target normal.

The experimental results are summarized in Fig. 3. Electron-beam energy distributions from Si microwire arrays are shown in red and the distributions from flat targets are shown in black. The electron-beam energy distributions recorded with flat interfaces are similar. In both Figs. 3(a) and 3(b), the cutoff energy for the electron beam is around 30 MeV. A significant enhancement in the total number of electrons and their mean energy is obtained with Si microwire arrays. The structured target in Fig. 3(a) yielded a cutoff energy of 70 MeV, while the structured target in Fig. 3(b) yielded 60 MeV. For both structured targets, two electron populations characterize

the spectra: a low-energy population in the range of 0.5–20 MeV and a high-electron-energy population that peaks around 25 MeV and extends to the 60–70 MeV range. This suggests, as seen in the simulations, that the spectrum is a combination of electrons from the bulk of the target and electrons from the wires that were accelerated by DLA. An exponential fit to the data gives  $kT_e = 18 \text{ MeV}$  and  $kT_e = 11 \text{ MeV}$  for the data in Figs. 3(a) and 3(b), respectively. The difference in the two spectra for the structured targets could be due to variations in the wire length, laser-beam alignment, or both. All the structured targets were cut from a larger substrate.

The simulations in Fig. 1 were carried out at normal incidence to elucidate the mechanism. We conducted an additional series of 3D simulations with the same laser incidence angle and wire spacing as the experimental one. The overall shape of the spectrum is similar to that at normal incidence [Fig. 1(d)]. However, the cutoff energies are modified. The maximum electron-beam energy increased from 20 to 30 MeV for the flat target. The maximum energy for the Si array decreased from 90 to 80 MeV. Both results are in good agreement with the experimental values for the cutoff energies. We also investigated the effect of laser pointing on the maximum attainable energy. The result is alignment dependent. We compared simulation results for two cases: the case where the laser is symmetrically incident between four wires, and the extreme case where the laser is incident on one wire. The spectra for the two cases are similar up to 50 MeV, but a higher cutoff energy (140 MeV) is observed for the second case. The electron acceleration becomes more efficient for shots aligned exactly on a wire because of the close proximity to the most intense part of the pulse. The effects of the surrounding wires were investigated by comparing the results of four wires only to that of the entire array. The electron-beam energy spectra and maximum energies were almost identical.

In conclusion, we report on the first successful proof-of-principle demonstration of microengineering laser plasma interactions. By manipulating light-matter interactions on the micro- and nanoscales, various processes such as ion acceleration and electron-positron pair production can be controlled and optimized. This work brings nano- and microscience to high-field physics and will open new paths towards plasma microphotonics with ultraintense tabletop lasers.

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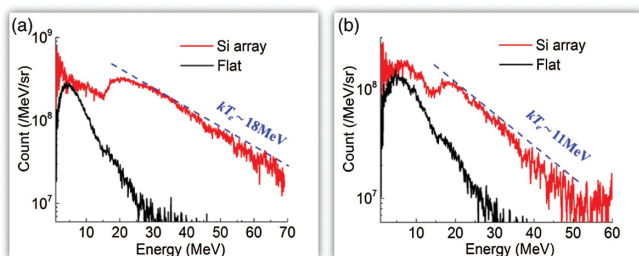


FIG. 3. Experimental results: escaping electron energy distributions for four laser shots, with flat target spectra (black) and Si array spectra (red). (a) Si array target 1 and baseline flat substrate, both with 20- $\mu\text{m}$ -thick Cu foil adhered to the rear side. (b) Si array target 2 and baseline flat substrate.

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